

<b>Notice of References Cited</b>	Application/Control No. 10/784,058	Applicant(s)/Patent Under Reexamination KO, CHUNG-WEN	
	Examiner Angela M. Lie	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-2004/0066123	04-2004	Fukuda, Yoshinori	313/114
B	US-5,686,979	11-1997	Weber et al.	349/96
C	US-2004/0160657	08-2004	Tonar et al.	359/265
D	US-6,247,820	06-2001	Van Order, Kim	359/604
E	US-6,211,613	04-2001	May, Paul	313/504
F	US-6,759,945	07-2004	Richard, David A.	349/179
G	US-2005/0152018	07-2005	Abramson et al.	359/265
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

**FOREIGN PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

**NON-PATENT DOCUMENTS**

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
U					
V					
W					
X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.